





**OPA3S2859** SBOSA13A - MAY 2022 - REVISED AUGUST 2022

# OPA3S2859 Dual-Channel, 900-MHz, 2.2-nV/ $\sqrt{\text{Hz}}$ , Programmable Gain Transimpedance **Amplifier**

#### 1 Features

Gain bandwidth product: 900 MHz

Internal switches for programmable gain

High impedance FET inputs

Input voltage noise: 2.2 nV/√Hz

Slew rate: 350 V/µs

Supply voltage range: 3.3 V to 5.25 V

Quiescent current: 22 mA/channel

Power down mode I<sub>O</sub>: 75 µA

Temperature range: -40 °C to 125 °C

### 2 Applications

Switchable transimpedance amplifier

Smart munitions

Laser distance measurement

Optical time domain reflectometry (OTDR)

Silicon photomultiplier (SiPM) buffer

Photomultiplier tube post amplifier

High speed programmable gain amplifier

# FB\_A0 ΣŅ VS-INA+ SEL1 LTCH\_A VS+ LTCH\_B PD VS+ SEL0 INB+ VS-

**Block Diagram** 

### 3 Description

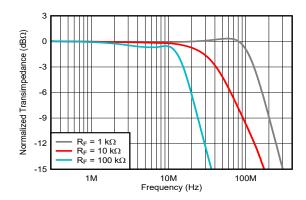
OPA3S2859 is а wideband. low-noise programmable gain amplifier with CMOS inputs for wideband transimpedance and voltage amplifier applications. When the device is configured as a transimpedance amplifier (TIA), the 0.9-GHz gain bandwidth product (GBWP) enables high closedloop bandwidths in low-capacitance photodiode (PD) applications.

The three internal switched feedback paths along with an optional parallel non-switched feedback path allows for up to four selectable gain configurations. The internal switches minimize parasitic contributions to increase performance compared to systems that use discrete external switches. Each switch is optimized for feedback resistor values ranging from < 1 k $\Omega$  to > 100 k $\Omega$  for wide dynamic range applications. The selected switch path is controlled for both channels using a 2-wire parallel interface. For each channel selected, the gain path can also be held constant by exerting the latch pin, which subsequently disables switch control for the selected channel and prevents the channel from changing gain.

### Package Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
OPA3S2859	WQFN (24)	4.00 mm × 4.00 mm

See the package option addendum at the end of the data sheet for all available packages.



Transimpedance Bandwidth vs Frequency



### **Table of Contents**

1 Features	1	8.4 Device Functional Modes	.18
2 Applications		9 Application and Implementation	.20
3 Description		9.1 Application Information	
4 Revision History		9.2 Typical Application	
5 Pin Configuration and Functions		10 Power Supply Recommendations	
6 Specifications		11 Layout	
6.1 Absolute Maximum Ratings		11.1 Layout Guidelines	22
6.2 ESD Ratings		11.2 Layout Examples	.22
6.3 Recommended Operating Conditions		12 Device and Documentation Support	
6.4 Thermal Information	5	12.1 Device Support	
6.5 Electrical Characteristics	6	12.2 Documentation Support	
6.6 Switching Characteristics	8	12.3 Receiving Notification of Documentation Updates.	
6.7 Typical Characteristics		12.4 Support Resources	
7 Parameter Measurement Information		12.5 Trademarks	
8 Detailed Description	17	12.6 Electrostatic Discharge Caution	
8.1 Overview		12.7 Glossary	
8.2 Functional Block Diagram		13 Mechanical, Packaging, and Orderable	
8.3 Feature Description		Information	. 25

## **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

# Changes from Revision \* (September 2020) to Revision A (August 2022)Page• Changed the status of the data sheet from: Advanced Information to: Production Data1

# **5 Pin Configuration and Functions**

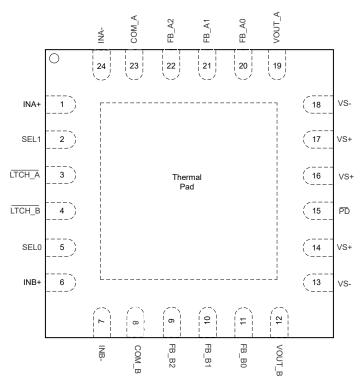


Figure 5-1. RTW Package, 24-Pin WQFN With Exposed Thermal Pad (Top View)

**Table 5-1. Pin Functions** 

F	PIN	TYPE(1)	DESCRIPTION
NAME	NO.	TIPE	DESCRIPTION
COM_A	23	I	Photodiode input – Channel A
COM_B	8	I	Photodiode input – Channel B
FB_A0	20	1	Feedback connection to Channel A – TIA Gain Resistor (Low gain, optimized for gain in < 10 k $\Omega$ range)
FB_A1	21	ı	Feedback connection to Channel A – TIA Gain Resistor (Mid gain, optimized for gain in 10 k $\Omega$ – 100 k $\Omega$ range)
FB_A2	22	1	Feedback connection to Channel A – TIA Gain Resistor (High gain, optimized for gain in > 100 k $\Omega$ range)
FB_B0	11	ı	Feedback connection to Channel B – TIA Gain Resistor (Low gain, optimized for gain in < 10 k $\Omega$ range)
FB_B1	10	1	Feedback connection to Channel B – TIA Gain Resistor (Mid gain, optimized for gain in 10 k $\Omega$ – 100 k $\Omega$ range)
FB_B2	9	1	Feedback connection to Channel B – TIA Gain Resistor (High gain, optimized for gain in > 100 k $\Omega$ range)
INA-	24	I	Negative (inverting) input for amplifier A
INA+	1	I	Positive (noninverting) input for amplifier A
INB-	7	I	Negative (inverting) input for amplifier B
INB+	6	ı	Positive (noninverting) input for amplifier B



### **Table 5-1. Pin Functions (continued)**

PI	IN	TYPE(1)	DESCRIPTION		
NAME	NO.	ITPE	DESCRIPTION		
LTCH_A	3	I	Latch control input for Channel A. LTCH_A = logic high (default) = transparent mode, gain setting changes based on SEL0 and SEL1 pins are reflected at the output.  LTCH_A = logic low = latch mode = changing SEL0 and SEL1 pins does not affect the gain configuration of amplifier.		
ІТСН_В	4	I	Latch control input for Channel B. LTCH_B = logic high (default) = transparent mode, gain setting changes based on SEL0 and SEL1 pins are reflected at the output.  LTCH_B = logic low = latch mode = changing SEL0 and SEL1 pins does not affect the gain configuration of amplifier.		
PD	15	I	Power down pin. $\overline{PD}$ = logic high (default) = normal operation, $\overline{PD}$ = logic low = power down mode.		
SEL0	5	I	TIA gain selection. SEL0 = logic high (default). See Table 5-2 for details.		
SEL1	2	I	TIA gain selection. SEL1 = logic high (default). See Table 5-2 for details.		
VOUT_A	19	0	Output of amplifier A		
VOUT_B	12	0	Output of amplifier B		
VS-	13, 18	I	Negative (lowest) power supply		
VS+	14, 16, 17	I	Positive (highest) power supply		
Thermal pad		_	Connect the thermal pad to the most negative power supply (pin 13 and 18) of the device under test (DUT).		

(1) I = input, O = output

### Table 5-2. Select Pin Decoder

SEL1	SEL0	Gain
LOW	HIGH	Low Gain, optimized for gain in < 10 kΩ range
LOW	LOW	Mid Gain, optimized for gain in 10 k $\Omega$ – 100 k $\Omega$ range
HIGH	LOW	High Gain, optimized for gain in > 100 kΩ range
HIGH (Default)	HIGH (Default)	External Gain. All internal switches open

Product Folder Links: OPA3S2859

omit Document Feedback



### **6 Specifications**

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Vs	Total supply voltage (V <sub>S+</sub> - V <sub>S-</sub> )		5.5	V
V <sub>IN+</sub> , V <sub>IN-</sub>	Input voltage	(V <sub>S-</sub> ) - 0.5	$(V_{S+}) + 0.5$	V
V <sub>ID</sub>	Differential input voltage		1	V
V <sub>OUT</sub>	Output voltage	(V <sub>S-</sub> ) - 0.5	$(V_{S+}) + 0.5$	V
I <sub>IN</sub>	Continuous input current		±4	mA
I <sub>OUT</sub>	Continuous output current <sup>(2)</sup>		25	mA
TJ	Junction temperature		150	°C
T <sub>A</sub>	Operating free-air temperature	-40	125	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

<sup>(1)</sup> Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If briefly operating outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

### 6.2 ESD Ratings

			VALUE	UNIT
V	Liootiootatio	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	±1500	\/
V <sub>(ESD)</sub>	discharge	Charged device model (CDM), per JEDEC specification JEDEC JS-002, all pins <sup>(2)</sup>	±1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### **6.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Vs	Total supply voltage (V <sub>S+</sub> - V <sub>S-</sub> )	3.3	5	5.25	V
T <sub>A</sub>	Ambient temperature	-40		125	°C

#### 6.4 Thermal Information

		OPA3S2859	
	THERMAL METRIC <sup>(1)</sup>	RTW	UNIT
		24 PINS	
R <sub>0JA</sub>	Junction-to-ambient thermal resistance	52	°C/W
R <sub>0</sub> JC(top)	Junction-to-case (top) thermal resistance	39.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	28.2	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	1.8	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	28.2	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	13.3	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

<sup>(2)</sup> Long-term continuous output current for electromigration limits

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



### **6.5 Electrical Characteristics**

 $V_{S+}$  = 5 V,  $V_{S-}$  = 0 V,  $R_L$  = 200  $\Omega$ , output load is referenced to midsupply, input common-mode biased at midsupply, and  $T_A \approx +25^{\circ}\text{C}$  (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
AC PERF	ORMANCE					
		$V_{OUT}$ = 100 m $V_{PP}$ , Gain = 1 k $\Omega$ , $C_{IN}$ = 4 pF		130		MHz
SSBW	Small-signal transimpedance bandwidth <sup>(1)</sup>	$V_{OUT}$ = 100 m $V_{PP}$ , Gain = 10 k $\Omega$ , $C_{IN}$ = 4 pF		40		MHz
	Dallawidin	$V_{OUT}$ = 100 m $V_{PP}$ , Gain = 100k $\Omega$ , Cin = 4 pF		14		MHz
GBWP	Gain-bandwidth product			900		MHz
	Slew rate (10% - 90%)	V <sub>OUT</sub> = 2-V step		350		V/µs
e <sub>n</sub>	Input-referred voltage noise	f = 1 MHz		2.2		nV/√Hz
Z <sub>OUT</sub>	Closed-loop output impedance	f = 1 MHz		0.02		Ω
DC PERF	ORMANCE					
A <sub>OL</sub>	Open-loop voltage gain	f = DC	70	76		dB
Vos	Input offset voltage	T <sub>A</sub> = 25 °C	-8	±0.9	8	mV
ΔV <sub>OS</sub> /ΔΤ	Input offset voltage drift	T <sub>A</sub> = -40°C to +125°C		-2		μV/°C
I <sub>BN</sub> , I <sub>BI</sub>	Input bias current <sup>(2)</sup>		-50		50	pA
I <sub>BOS</sub>	Input offset current <sup>(2)</sup>		-50		50	pА
CMRR	Common-mode rejection ratio	V <sub>CM</sub> = ±0.5 V (from midsupply)	67	78		dB
INPUTS						
C <sub>IN+</sub>	Non-inverting input capacitance			1.4		pF
C <sub>IN-</sub>	Inverting input capacitance (3)			3		pF
V <sub>IH</sub>	Common-mode input range (high)	CMRR > 64 dB	3.4	3.6		V
V <sub>IH</sub>	Common-mode input range (high)	CMRR > 64 dB , V <sub>S+</sub> = 3.3 V	1.7	1.9		V
V <sub>IL</sub>	Common-mode input range (low)	CMRR > 64 dB		0	0.4	V
V <sub>IL</sub>	Common-mode input range (low)	CMRR > 64 dB , V <sub>S+</sub> = 3.3 V		0	0.4	V
OUTPUT	S				'	
V <sub>OH</sub>	Output voltage (high)	T <sub>A</sub> = 25 °C	3.95	4.1		V
V <sub>OH</sub>	Output voltage (high)	V <sub>S+</sub> = 3.3 V, T <sub>A</sub> = 25 °C	2.3	2.4		V
V <sub>OL</sub>	Output voltage(low)	T <sub>A</sub> = 25 °C		1.1	1.2	V
V <sub>OL</sub>	Output voltage(low)	V <sub>S+</sub> = 3.3 V, T <sub>A</sub> = 25 °C		1.05	1.15	V
I <sub>O_LIN</sub>	Linear output drive (source and sink)	R <sub>L</sub> = 10 Ω, A <sub>OL</sub> > 52 dB	65	74		mA
CHANNE	L-TO-CHANNEL MATCHING					
	Crosstalk (output-referred)	f = 1 MHz, Gain = 100 kΩ, V <sub>OUT</sub> = 100 mV <sub>PP</sub>		-70		dB
	Offset voltage mismatch			±1		mV
	Offset current mismatch		-20		20	pА

Product Folder Links: OPA3S2859

### 6.5 Electrical Characteristics (continued)

 $V_{S+}$  = 5 V,  $V_{S-}$  = 0 V,  $R_L$  = 200  $\Omega$ , output load is referenced to midsupply, input common-mode biased at midsupply, and  $T_A \approx +25^{\circ}\text{C}$  (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER	SUPPLY					
		V <sub>S+</sub> = 5 V		44	53	mA
$I_Q$	Quiescent current (both channels)	V <sub>S+</sub> = 5 V, T <sub>A</sub> = +125°C		51		mA
		V <sub>S+</sub> = 5 V, T <sub>A</sub> = -40°C		39		mA
PSRR+	Power Supply Rejection Ratio	f = DC	74	85		dB
PSRR-	Power Supply Rejection Ratio	f = DC	68	72		dB
POWER	DOWN					
	Disable voltage threshold	Voltage referenced to V <sub>S+</sub> , amplifier OFF below this voltage	V <sub>S+</sub> - 1.5	V <sub>S+</sub> - 1.3		V
	Enable voltage threshold	Voltage referenced to $V_{S+}$ , amplifier ON above this voltage		V <sub>S+</sub> - 1.2	V <sub>S+</sub> - 0.8	V
	Power-down quiescent current			75	140	μA
	PD bias current	$V_{PD} = V_{S-}$ or $V_{S+}$		6		μA
	PD bias current	V <sub>PD</sub> at switching threshold		160		μΑ
	Turnon time delay	Time to V <sub>OUT</sub> = 90% of final value		90		ns
	Turnoff time delay	Time to V <sub>OUT</sub> = 10% of final value		330		ns
	·	·				

<sup>(1)</sup> C<sub>IN</sub> = Photodiode capacitance + PCB capacitance. Photodiode capacitance is 3.3 pF and estimated PCB capacitance is 0.7 pF.

<sup>(2)</sup> Leakage currents from switches are not included in this measurement.

<sup>(3)</sup> C<sub>IN-</sub> refers to the capacitance at the inverting input of the amplifier. C<sub>IN-</sub> = C<sub>IN-(CM)</sub> + C<sub>DIFF</sub> + Switch capacitance on the amplifier inverting pin (ON capacitance of the closed switch + OFF capacitance for open switches).



### **6.6 Switching Characteristics**

 $V_{S+}$  = 5 V,  $V_{S-}$  = 0 V, input common-mode biased at midsupply,  $R_{F0}$  = 1 k $\Omega$ ,  $R_{F1}$  = 10 k $\Omega$ ,  $R_{F2}$  = 100 k $\Omega$ ,  $R_{L}$  = 200  $\Omega$ , output load is referenced to midsupply, and  $T_A \approx +25^{\circ}C$  (unless otherwise noted), see figure 7-1 for schematic configuration. (1) (2)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
GAIN SWIT	CHES				
		SW <sub>0</sub> OFF to SW <sub>1</sub> ON	160		
		SW <sub>0</sub> OFF to SW <sub>2</sub> ON	230		
	Switch transition-time <sup>(5)</sup>	SW <sub>1</sub> OFF to SW <sub>0</sub> ON	80		
	Switch transition-time (*)	SW <sub>1</sub> OFF to SW <sub>2</sub> ON	230		ns
		SW <sub>2</sub> OFF to SW <sub>0</sub> ON	80		
		SW <sub>2</sub> OFF to SW <sub>1</sub> ON	110		
C <sub>COM0</sub>		SW <sub>COM0</sub> ON; SW <sub>COM1</sub> and SW <sub>COM2</sub> OFF	1.3		
C <sub>COM1</sub>	COM capacitance (3) (6)  FB capacitance (5) (7)	SW <sub>COM1</sub> ON; SW <sub>COM0</sub> and SW <sub>COM2</sub> OFF	1.2		
C <sub>COM2</sub>		SW <sub>COM2</sub> ON; SW <sub>COM0</sub> and SW <sub>COM1</sub> OFF	1.2		
C <sub>COM_OPEN</sub>		SW <sub>COM0</sub> , SW <sub>COM1</sub> and SW <sub>COM2</sub> OFF	1.2		
C <sub>FB0</sub>		SW <sub>0</sub> ON	1.9		nΕ
C <sub>FB1</sub>		SW <sub>1</sub> ON	1.6		pF
C <sub>FB2</sub>		SW <sub>2</sub> ON	1.5		
C <sub>FB0_OPEN</sub>		SW <sub>0</sub> OFF	1.4		
C <sub>FB1_OPEN</sub>		SW <sub>1</sub> OFF	1.2		
C <sub>FB2_OPEN</sub>		SW <sub>2</sub> OFF	1.1		
R <sub>ON_COM0</sub>			80		
R <sub>ON_FB0</sub>			38		
R <sub>ON_COM1</sub>	On resistance <sup>(8) (9)</sup>		125		Ω
R <sub>ON_FB1</sub>	Off resistance (7)		37		12
R <sub>ON_COM2</sub>			375		
R <sub>ON_FB2</sub>			35		
		SW <sub>COM0</sub> for Channel A and B	0.15		
	On resistance channel-to-channel matching <sup>(3)</sup> <sup>(4)</sup>	SW <sub>FB0</sub> for Channel A and B	0.4		
		SW <sub>COM1</sub> for Channel A and B	0.45		Ω
		SW <sub>FB1</sub> for Channel A and B	0.07		22
		SW <sub>COM2</sub> for Channel A and B	3		
		SW <sub>FB2</sub> for Channel A and B	0.12		

Submit Document Feedback

### 6.6 Switching Characteristics (continued)

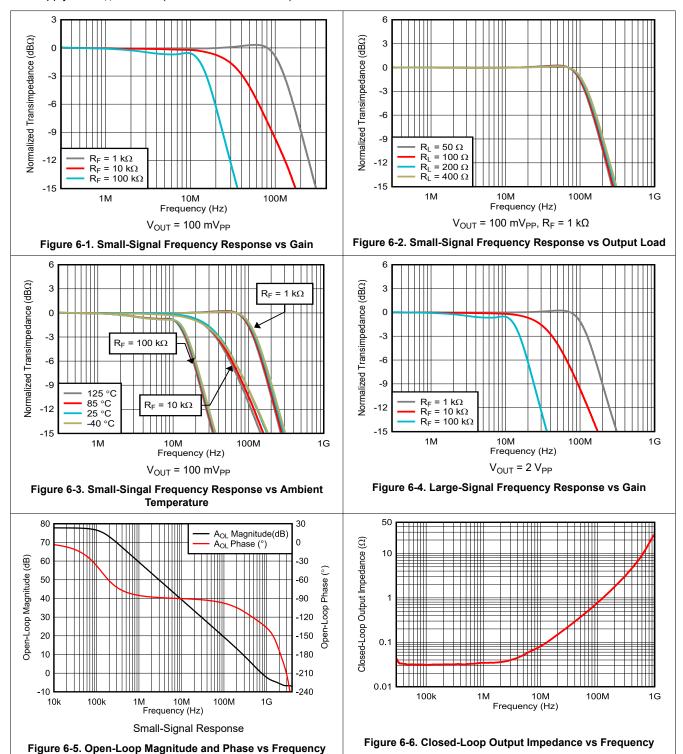
 $V_{S+}$  = 5 V,  $V_{S-}$  = 0 V, input common-mode biased at midsupply,  $R_{F0}$  = 1 kΩ,  $R_{F1}$  = 10 kΩ,  $R_{F2}$  = 100 kΩ,  $R_{L}$  = 200 Ω, output load is referenced to midsupply, and  $R_{L}$  = +25°C (unless otherwise noted), see figure 7-1 for schematic configuration. (1) (2)

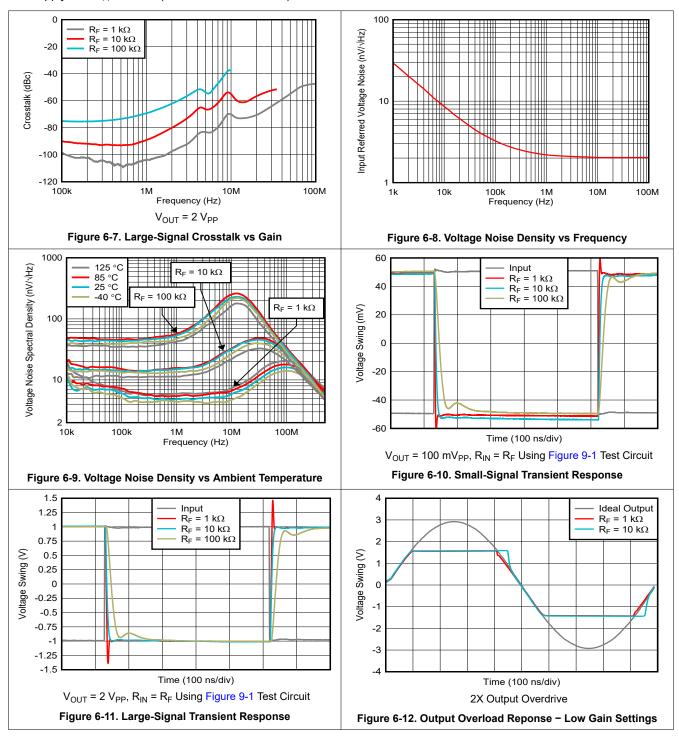
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
LOGIC PIN	FUNCTION (LATCH, SEL)						
	Logic low threshold	Logic low below the threshold voltage	V <sub>S+</sub> - 1.5	V <sub>S+</sub> - 1.3		V	
	Logic high threshold	Logic high above the threshold voltage		V <sub>S+</sub> - 1.2	V <sub>S+</sub> - 0.8	V	
	Bias current	$V_{PIN} = V_{S-}$ or $V_{S+}$		6		μA	
	Bias current	V <sub>PIN</sub> at switching threshold		160		μA	
	Setup time		100			ns	
	Hold time		100			ns	

- (1) All the specifications apply for both Channels A and B, unless otherwise noted.
- (2) When switching from one gain condition to another, the new gain switches are closed before opening the previous gain switches (make-before-break).
- (3) SW<sub>COM0</sub>, SW<sub>COM1</sub>, SW<sub>COM2</sub> refer to switch on the common-mode side (COM) for the different gain options.
- (4) SW<sub>FB0</sub>, SW<sub>FB1</sub>, SW<sub>FB2</sub> refer to switch on the feedback side (FB) for the different gain options.
- (5) SW<sub>0</sub>, SW<sub>1</sub>, SW<sub>2</sub> refers to the two switches needed for a given gain condition. For example, SW0 refers to SW<sub>COM0</sub> and SW<sub>FB0</sub>.
- (6) C<sub>COM0</sub>, C<sub>COM1</sub>, C<sub>COM2</sub> is the capacitance at the COM pin for different gain options. It is equal to ON capacitance of closed switch + OFF capacitance of open switches.
- (7) C<sub>FB0</sub>, C<sub>FB1</sub>, C<sub>FB2</sub> is the capacitance at the FB<sub>X</sub> pin. It is equal to ON capacitance of the gain option selected (SW<sub>COM0</sub> + SW<sub>FB0</sub> capacitance).
- (8) R<sub>ON\_COM0</sub>, R<sub>ON\_COM1</sub>, R<sub>ON\_COM2</sub>, refer to ON resistance for the COM side switch.
- (9) R<sub>ON FB0</sub>, R<sub>ON FB1</sub>, R<sub>ON FB2</sub>, refer to ON resistance for the FB side switch.



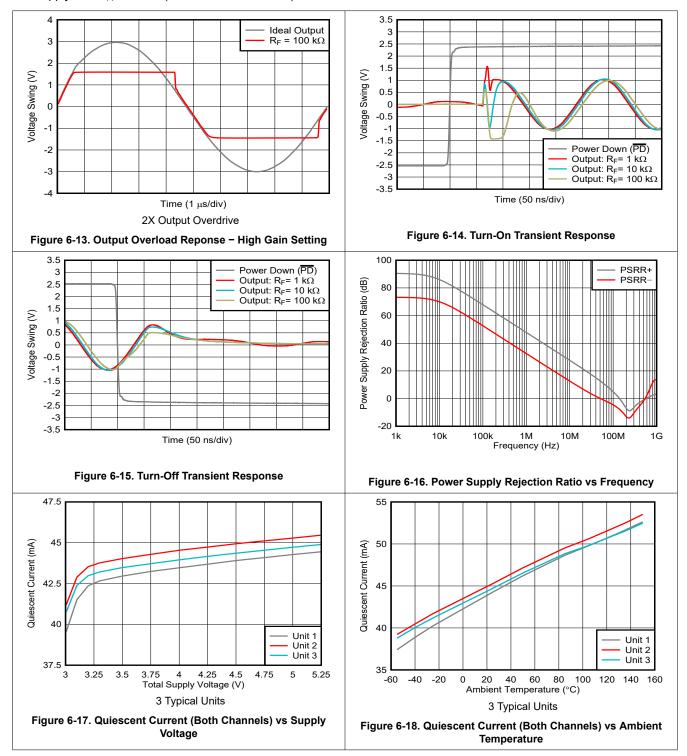
### 6.7 Typical Characteristics





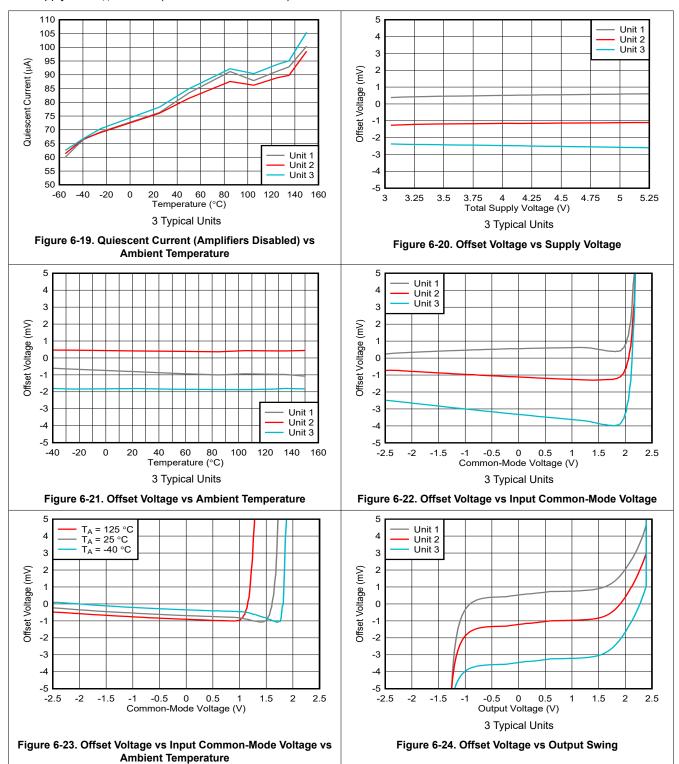


 $V_{S+}$  = +2.5 V,  $V_{S-}$  = -2.5 V,  $R_L$  = 200  $\Omega$ ,  $C_{IN}$  = 4 pF, output load is referenced to mid-supply, input common-mode biased at mid-supply, and  $T_A \cong$  +25°C (unless otherwise noted)

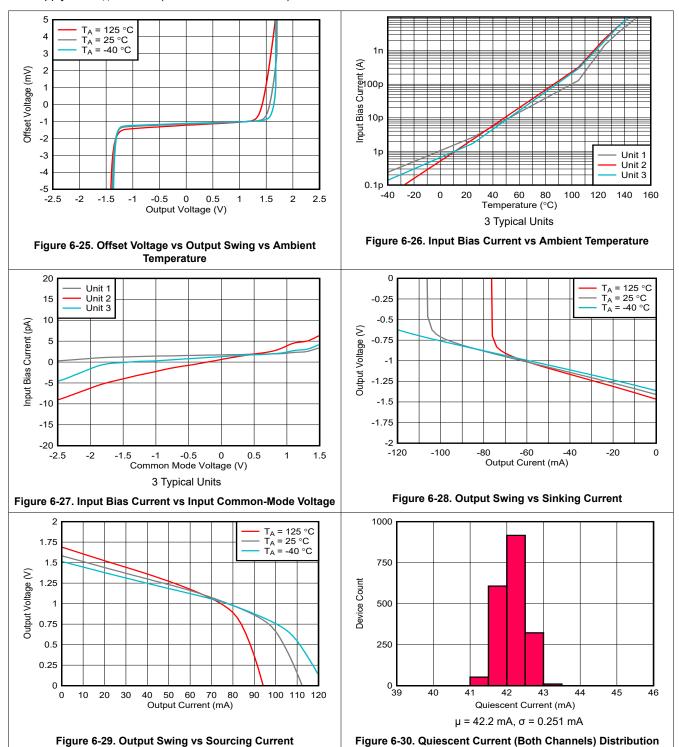


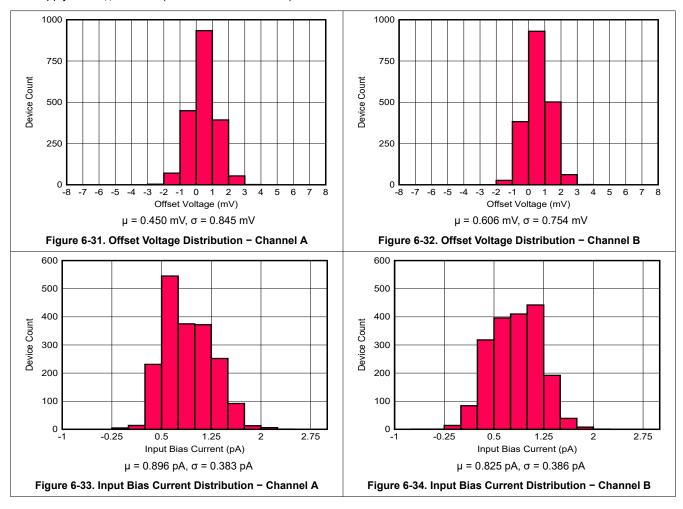
Submit Document Feedback

Copyright © 2022 Texas Instruments Incorporated











### 7 Parameter Measurement Information

The following figure shows the test setup configuration for OPA3S2859.

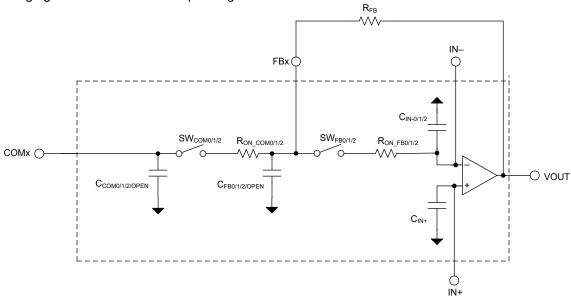


Figure 7-1. Switching Characteristics Configuration

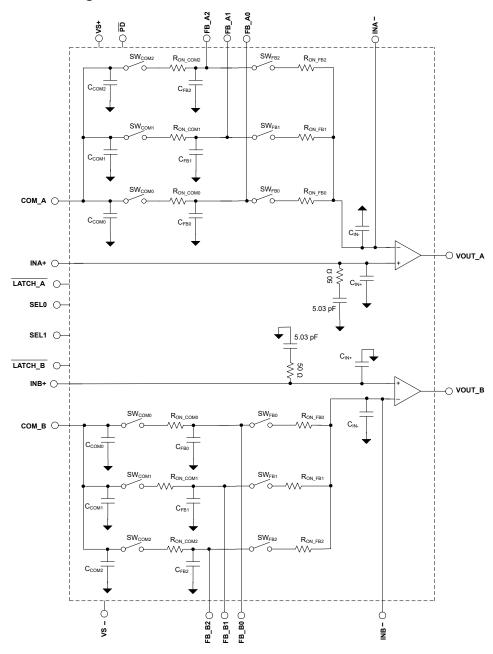
### 8 Detailed Description

### 8.1 Overview

The OPA3S2859 features dual channel, high-speed, low noise, wide gain bandwidth amplifier with programmable gain switches to offer a compact, easy-to-use device for wideband transimpedance applications, high-speed data acquisition systems, and applications with weak signal inputs that require low-noise and high-gain front ends. Integrated switches allow for multiple gain settings on a single amplifier stage without the need for an additional multiplexer, therefore minimizing board parasitics.

The OPA3S2859 is offered in a 4-mm × 4-mm, 24-pin WQFN package that features multiple feedback (FB) pins for different gain options to make simple feedback network connection between the amplifier output and inverting input. The three internally switched feedback paths along with an additional parallel non-switched feedback path allows for up to four selectable gain configurations.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

#### 8.3.1 Programmable Gain

The OPA3S2859 features integrated switches that can be used for implementing different gain configurations. The closed-loop bandwidth and noise of a TIA are affected by the transimpedance gain and photodiode capacitance. The OPA3S2859 has a higher bandwidth in its low-gain configuration for a given value of photodiode capacitance compared to the high-gain configuration. Increasing the gain of the TIA stage by a factor of X increases the output signal by a factor X, but the noise contribution from the resistor only increases by  $\sqrt{X}$ . The input-referred noise density of the low-gain configuration is therefore higher than the input-referred noise density of the high-gain configuration.

OPA3S2859 provides control for switching among three independently-configured external feedback networks using FB\_x0, FB\_x1, FB\_x2 pins, and allows for up to four selectable gain configurations with an additional parallel non-switched feedback path. The internal switches minimize parasitic contributions to increase performance compared to external methods. Each switch is optimized for increasing feedback resistor values ranging from < 1 k $\Omega$  to > 100 k $\Omega$  for wide dynamic range applications. The selected switch path is controlled for both channels using a 2-wire parallel interface (SEL0 and SEL1).

In many systems it is typical that gain will switch sequentially (also known as adjacent gain switching). For example, the gain will switch low to medium to high or high to medium to low. When switching between adjacent gains, the switches feature make-before-break switching. When programmed to a different connection, the previous switch does not change to high impedance state until the new switch is closed (with a typical 80 ns to 230 ns delay when both switches are closed). This feature helps the amplifier from not operating in an open-loop state when the switches are used in a switched-gain transimpedance configuration.

#### 8.3.2 Slew Rate

The OPA3S2859 features a high slew rate of 350 V/µs. The slew rate is a critical parameter in high-speed pulse applications such as optical time-domain reflectometry (OTDR). As Figure 6-11 shows, the high slew rate implies that the device accurately reproduces a 2-V, sub 100-ns pulse edge. The wide bandwidth and slew rate of the device make it an excellent amplifier for high-speed signal-chain front ends.

#### 8.3.3 Input and ESD Protection

The OPA3S2859 is fabricated on a low-voltage, high-speed, BiCMOS process. The internal, junction breakdown voltages are low for these small geometry devices, and as a result, all device pins are protected with internal ESD protection diodes to the power supplies. There are two antiparallel diodes between the inputs of the amplifier that clamp the inputs during an overrange or fault condition.

#### 8.4 Device Functional Modes

### 8.4.1 Split-Supply and Single-Supply Operation

The OPA3S2859 can be configured with single-sided supplies or split-supplies without degrading performance. In either case, the thermal pad should be tied to the same voltage as V<sub>S</sub>.

#### 8.4.2 Power-Down Mode

The OPA3S2859 features a power-down mode to conserve power. Connecting the  $\overline{PD}$  pin low disables the amplifier thereby reducing the quiescent current and places the output in a high-impedance state.

PD pin has an internal pull up resistor. If the pin is left floating, then the device defaults to an ON state. The PD disable and enable threshold voltages are referenced to the positive supply (for more inforamtion refer to the *Electrical Characteristics* section). If the amplifier is configured with the positive supply at 5 V and the negative supply at ground, then the disable and enable threshold voltages are 3.5 V and 4.2 V, respectively. If the amplifier is configured with ±2.5 V supplies, then the threshold voltages are at 1 V and 1.7 V.

#### 8.4.3 Gain Select Mode (SEL)

The OPA3S2859 features two pins SEL0 and SEL1 to choose between three different internal switch networks and an external option. The SELx disable and enable threshold voltages are with reference to the positive supply as shown in the *Switching Characteristics* table. Note: while the SELx logic will select the same switch configuration for channel A and B, the external components (feedback network) of channels A and B do not have to be exactly the same.

When switching between different gain settings (feedback networks), the device has a transition time of only 80 ns to 230 ns (typical) as shown in the *Switching Characteristics* table. In many systems, it is typical that gain will be stepped sequentially (for example, low to medium to high or high to medium to low). As provided in Table 5-2, the SELx logic assignment ensures that switching gains up or down involve only one input-pin transition, reducing the probability of unintended false codes during logic settling.

#### 8.4.4 Latch Mode

OPA3S2859 features LTCH\_A and LTCH\_B pins which independently latch the gain configuration for Channel A and Channel B, respectively. If the latch control inputs are connected to logic high or floating, then the chosen feedback selection (through the SEL0 and SEL1 pins) applies to A and B analog channels immediately, this is also called transparent mode. If the latch control inputs are logic low, then changing the feedback selection (through the SEL0 and SEL1 pins) does not affect the gain configuration of the respective amplifier channel. Figure 8-1 shows the minimum timing requirements that should be met when using LTCH\_x pins to latch gain configuration.

As shown in Figure 8-1, use the latch control input for each channel to separately control the feedback selection from the common SEL1 and SEL0 pins. The latch control inputs can also provide benefits in some cases where channel A and B need to have the same configuration. For example, any timing skew from SEL1 and SEL0 may result in unintended switch logic configurations for a short-duration resulting in transient output glitch when switching between different settings in transparent mode. Holding the LTCH\_x pin low until the new selection value at the SEL pins have settled can minimize these intermediate glitch states.

This feature is also useful in larger systems with multiple OPA3S2859 devices. The gain path can be set using common SEL0 and SEL1 signals for all the devices, and latch pins can be used to control the gain independently for each amplifier channel.

The steps to update the gain settings in the following example configuration for Channel A only, are as follows:

- 1. Set LTCH\_B to logic low (latch mode), this way changes made on Channel A do not affect Channel B gain configuration.
- 2. If LTCH\_A is high (transparent mode), then use SEL0 and SEL1 pins to select the feedback network of interest. If LTCH\_A is low, then toggle it to logic high and use SEL0 and SEL1 pins to select the feedback network of interest.
- 3. To hold the selected gain, set LTCH\_A to logic low. Ensure minimum setup time requirements (100 ns) are met between SELx selection to LTCH\_A going low. Also, ensure that during the hold time (100 ns), no changes should be made on SELx pins. The minimum timing is based on internal device configuration. If needed, additional time must be added due to board layout parasitics and signal delays.
- 4. Gain setting for channel A is now latched and any changes on the SELx pins will not change the gain configuration for channel A.

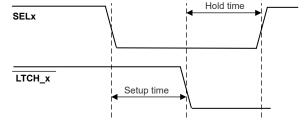


Figure 8-1. Timing Diagram

### 9 Application and Implementation

#### **Note**

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 9.1 Application Information

The OPA3S2859 offers a unique combination of dual channel, wide bandwidth low noise amplifiers with integrated programmable gain switches. This combination makes this amplifier an excellent choice for photodiode transimpedance amplifier applications with variable gain needs.

### 9.2 Typical Application

Figure 9-1 shows the circuit used to measure transimpedance bandwidth of the OPA3S2859 with different feedback network setting options. This configuration imitates the impedance of the photodiode on the input of the TIA.

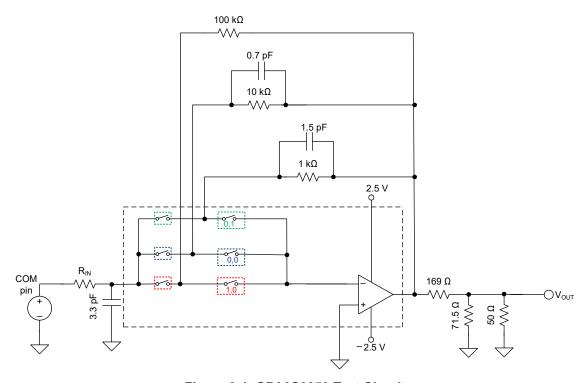


Figure 9-1. OPA3S2859 Test Circuit

### 9.2.1 Design Requirements

The objective is to design a variable gain, low noise, wideband optical front-end transimpedance amplifier. The design requirements are as follows:

- Amplifier supply voltage: ± 2.5 V
- Transimpedance gain:  $1 \text{ k}\Omega$ ,  $10 \text{ k}\Omega$ , or  $100 \text{ k}\Omega$
- Photodiode capacitance: C<sub>APD</sub> = 3.3 pF (additional estimated PCB capacitance = 0.7 pF)
- Target bandwidth: 130 MHz, 40 MHz, or 14 MHz

#### 9.2.2 Detailed Design Procedure

The OPA3S2859 meets the growing demand for wideband, low-noise photodiode amplifiers. The closed-loop bandwidth of a transimpedance amplifier is a function of the following:

- 1. The total input capacitance (C<sub>IN</sub>). This total includes the photodiode capacitance, the input capacitance of the amplifier (common-mode and differential capacitance) and any stray capacitance from the PCB.
- 2. The op amp gain bandwidth product (GBWP).
- 3. The transimpedance gain (R<sub>F</sub>).

Figure 9-1 shows the OPA3S2859 configured as programmable gain TIA using different feedback paths through the switch network. The feedback resistance ( $R_F$ ) and the input capacitance ( $C_{IN}$ ) form a zero in the noise gain that results in instability if left unchecked. To counteract the effect of the zero, a pole is inserted into the noise gain transfer function by adding the feedback capacitor ( $C_F$ ). The *Transimpedance Considerations for High-Speed Amplifiers Application Report* application report discusses theories and equations that show how to compensate a transimpedance amplifier for a particular transimpedance gain and input capacitance. The bandwidth and compensation equations from the application report are available in an Excel® calculator. *What You Need To Know About Transimpedance Amplifiers – Part 1* provides a link to the calculator.

The equations and calculators in the referenced application report and blog posts are used to model the bandwidth ( $f_{-3dB}$ ) and noise performance of the OPA3S2859 configured as a TIA. For this setup, to emulate an ideal current source, choose an  $R_{IN}$  value that is 1 to 10x greater than  $R_F$  so that the resulting low frequency noise gain is closer to 1 V/V than to 2 V/V ( $R_F$  = 1 k $\Omega$ , 10 k $\Omega$ , or 100 k $\Omega$ ,  $R_{IN}$  = 10 k $\Omega$ , 100 k $\Omega$ , or 100 k $\Omega$ ; respectively). Figure 9-2 shows the resultant performance. To maximize bandwidth, make sure to reduce any stray parasitic capacitance from the PCB. Increasing  $R_F$  results in lower bandwidth. To maximize the signal-to-noise ratio (SNR) in an optical front-end system, maximize the gain in the TIA stage.

#### 9.2.3 Application Curves

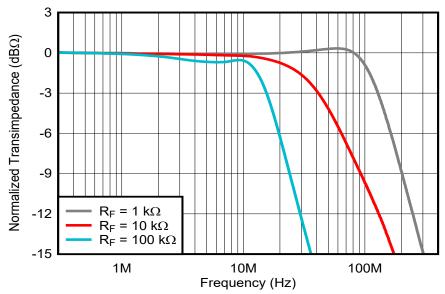


Figure 9-2. Bandwidth vs Frequency

### 10 Power Supply Recommendations

The OPA3S2859 operates on supplies from 3.3 V to 5.25 V. The device operates on single-sided supplies, split and balanced bipolar supplies, and unbalanced bipolar supplies. Because the OPA3S2859 does not feature rail-to-rail inputs or outputs, the input common-mode and output swing ranges are limited at 3.3-V supplies.

### 11 Layout

### 11.1 Layout Guidelines

Achieving optimum performance with a high-frequency amplifier, such as the OPA3S2859, requires careful attention to board layout parasitics and external component types. Recommendations that optimize performance include the following:

- Reduce capacitive coupling between feedback traces. Trace-to-trace capacitance between the three feedback connection traces can cause the traces to couple together at high frequency and effect the gain of the device. Particularly for high gain feedback configurations, capacitive coupling to feedback paths with lower gain can significantly reduce the bandwidth if not properly isolated. For example, in a circuit configuration with 100k, 10k, and 1k feedback elements, the 100k gain path can see over 66% reduction in bandwidth when using a non-optimized feedback layout. To properly isolate the feedback traces, it is important to space the traces out and pour ground plane between the traces to isolate their capacitance; additional trace length, however, does add further inductance and capacitance to the traces which can also effect performance. Therefore, it is important to balance the feedback area and trace length to best minimize the major parasitic effect. A good starting point is to use a design similar to the evaluation module with a feedback area of approximately 6 mm × 6 mm. This can then be adjusted depending on circuit limitations and
- Minimize parasitic capacitance from the signal I/O pins to ac ground. Parasitic capacitance on the output pins can cause instability, where as parasitic capacitance on the input pin reduces the amplifier bandwidth. To reduce unwanted capacitance, cut out the power and ground traces under the signal input pins, output pins, and exterior feedback trace when possible. A small value isolation resistor between the DUT output and feedback network can also help reduce the parasitic loading caused by the feedback trace on the output. Otherwise, ground and power planes must be unbroken elsewhere on the board.
- Minimize the distance from the power-supply pins to the high-frequency bypass capacitors. Use high-quality, 100-pF to 0.1-µF, C0G and NPO-type decoupling capacitors with voltage ratings at least three times greater than the amplifiers maximum power supplies. Place the smallest value capacitors on the same side as the DUT. If space constraints force the larger value bypass capacitors to be placed on the opposite side of the PCB, use multiple vias on the supply and ground side of the capacitors. This configuration makes sure that there is a low-impedance path to the amplifiers power-supply pins across the amplifiers gain bandwidth specification. Avoid narrow power and ground traces to minimize inductance between the pins and the decoupling capacitors. Larger (2.2-µF to 6.8-µF) decoupling capacitors that are effective at lower frequency must be used on the supply pins. Place these decoupling capacitors further from the device. Share the decoupling capacitors among several devices in the same area of the printed circuit board (PCB).

### 11.2 Layout Examples

Figure 11-1 shows a typical layout around the OPA3S2859 based on the evaluation module. The smallest decoupling capacitors were placed as close as possible to the DUT with wide metal area to minimize inductance. Special attention was placed on the feedback network layout to optimize the design for a typical application using 1 k $\Omega$ , 10 k $\Omega$ , and 100 k $\Omega$  feedback resistors. Figure 11-2 shows more details. The black colored areas under the input and feedback traces show the voids cut in the ground plane underneath the traces to minimize capacitance to ground as much as possible.

Product Folder Links: OPA3S2859

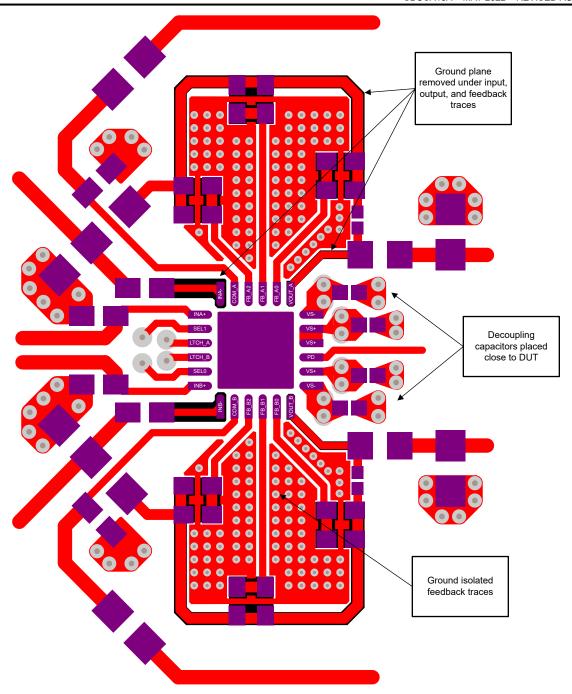


Figure 11-1. General Layout Example

Figure 11-2 shows an example of a feedback network from the evaluation module optimized to reduce the capacitive coupling between the feedback and output traces. Ground plane is poured between each of the feedback traces and component footprints as much as possible for the best isolation. A small isoation resistor (RISO) is connected between the output and feedback trace to help isolate the trace capacitance from being directly connected to the DUT output. Additionally, the ground plane is removed from under the feedback trace to further reduce the parasitic capacitance to ground created by the additional trace length required for the feedback network.



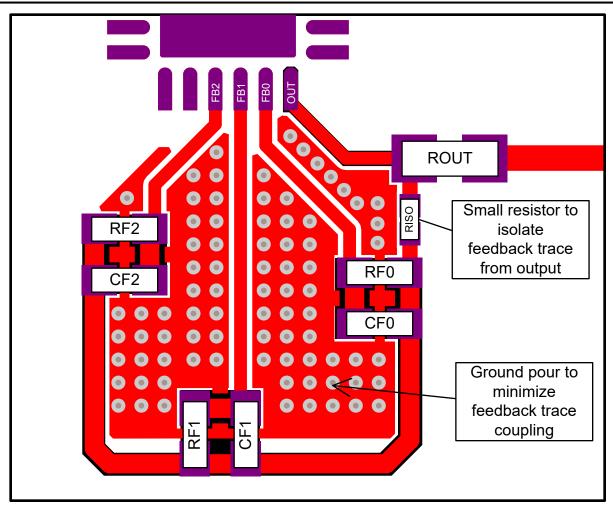


Figure 11-2. Feedback Network Layout Recommendations



# 12 Device and Documentation Support

### 12.1 Device Support

### 12.1.1 Development Support

- Texas Instruments, Optical Front-End System Reference Design design guide
- Texas Instruments, LIDAR-Pulsed Time-of-Flight Reference Design Using High-Speed Data Converters design guide
- · Texas Instruments, LIDAR Pulsed Time of Flight Reference Design design guide

### **12.2 Documentation Support**

#### 12.2.1 Related Documentation

See the following for related documentation:

- Texas Instruments, OPA3S2859 Evaluation Module user's guide
- Texas Instruments, Transimpedance Considerations for High-Speed Amplifiers application report
- Texas Instruments, What You Need To Know About Transimpedance Amplifiers Part 1 blog
- Texas Instruments, What You Need To Know About Transimpedance Amplifiers Part 2 blog
- Texas Instruments, Training Video: How to Design Transimpedance Amplifier Circuits
- · Texas Instruments, Training Video: High-Speed Transimpedance Amplifier Design Flow
- Texas Instruments, Training Video: How to Convert a TINA-TI Model into a Generic SPICE Model

### 12.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 12.4 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 12.5 Trademarks

TI E2E™ is a trademark of Texas Instruments.

Excel® is a registered trademark of Microsoft Corporation.

All trademarks are the property of their respective owners.

### 12.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 12.7 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

#### 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Copyright © 2022 Texas Instruments Incorporated

www.ti.com 9-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
OPA3S2859IRTWR	Active	Production	WQFN (RTW)   24	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	O3S2859
OPA3S2859IRTWR.B	Active	Production	WQFN (RTW)   24	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	O3S2859

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF OPA3S2859:

■ Enhanced Product : OPA3S2859-EP

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



# **PACKAGE OPTION ADDENDUM**

www.ti.com 9-Nov-2025

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 26-Jan-2025

### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA3S2859IRTWR	WQFN	RTW	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 26-Jan-2025



### \*All dimensions are nominal

Ì	Device Package Typ		Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
ı	OPA3S2859IRTWR	WQFN	RTW	24	3000	346.0	346.0	33.0	

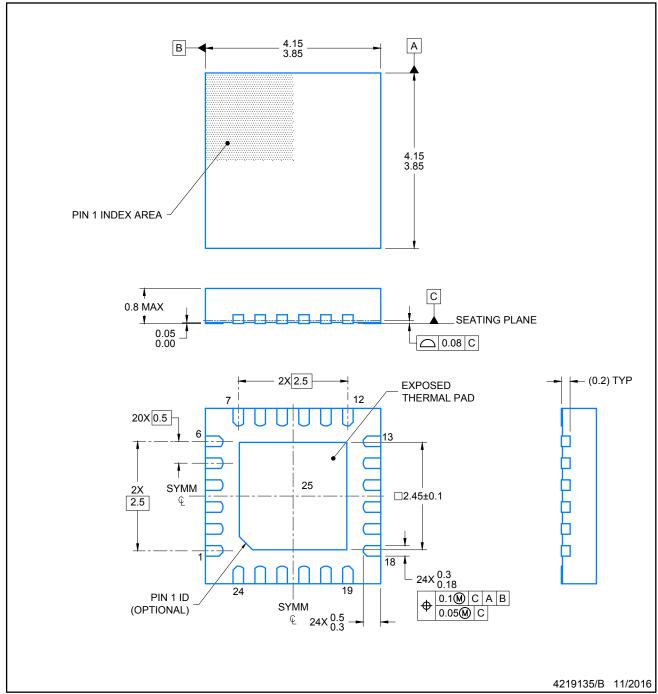
4 x 4, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



PLASTIC QUAD FLATPACK-NO LEAD

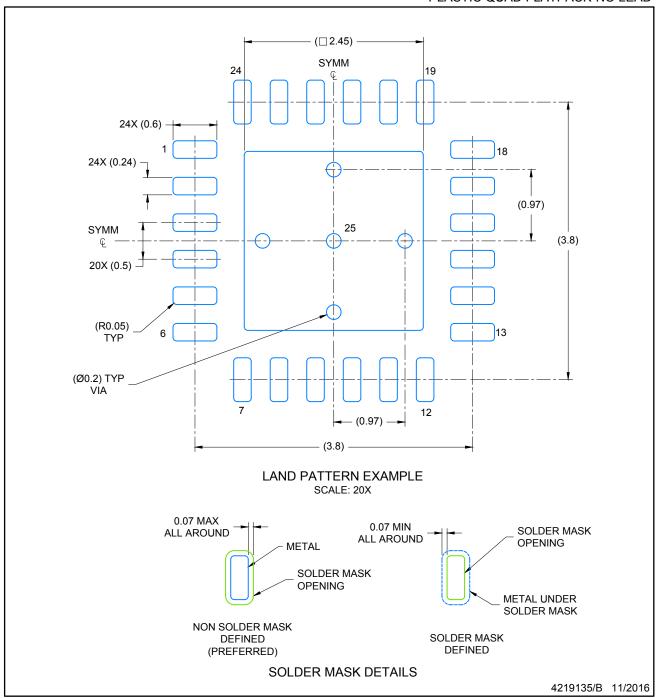


NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



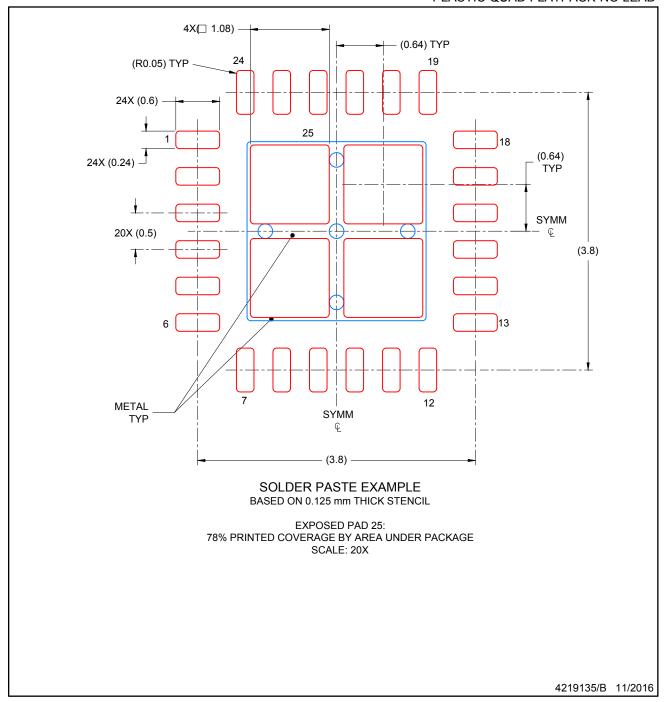
PLASTIC QUAD FLATPACK-NO LEAD



NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

PLASTIC QUAD FLATPACK-NO LEAD



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

#### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale, TI's General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2025, Texas Instruments Incorporated

Last updated 10/2025